

**PATENT APPLICATION**

Sheet 1 of 3

<b>FORM PTO-1449</b>  <b>LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT</b>  (Use several sheets if necessary)	ATTY. DOCKET NO. <b>10040025-1</b>	SERIAL NO.  APPLICANT <b>Lawrence Hakchu Lee et al.</b>
	FILING DATE <b>Dec. 11, 2003</b>	GROUP

## **REFERENCE DESIGNATION**

## **U.S. PATENT DOCUMENTS**

## **FOREIGN PATENT DOCUMENTS**

		DOCUMENT NUMBER	DATE	NAME	TRANSLATION
					YES NO

**OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)**

	"Laser and Optics", Agilent Technologies, User's Manual, pp. 7A-2 to 7C-21, 7G-2 to 7H-14.
	Philip Baumeister, "Optical Coating Technology", a book used at a five day short course, University of California at Los Angles University Extension, Department of Engineering, Information Systems and Technical Management, Jan. 12, 1998 t- Jan. 16, 1998, 15 pages.
	Paul Mauer, "Phase Compensation of Total Internal Reflection", Journal of the Optical Society of America, Vol. 56, No. 9, September 1966, pp. 1219-1221.
EXAMINER	DATE CONSIDERED

\* Copies of these references are not enclosed pursuant to 37 CFR 1.98(d). (See accompanying IDS)

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**OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)**

	Paul B. Mauer, "Modification of Phase-Compensated Corner Cube for Interferometry", Letters to the Editor, Vol. 57, p. 968.
	P. B. Kard, "On Elimination of the Doublet Structure of the Transmission Band in a Total-Reflection Light-Filter", Optics and Spectroscopy, Vol. VI, No. 3, March 1959, pp. 244-246.
	P. G. Kard, "On the Influence of Thin Films on Total Reflection", Optics and Spectroscopy, Vol. VI, No. 4, April 1959, pp. 339-341.

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Sheet 3 of 3

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		W. H. Steel, " Polarization-preserving rerereflectors", Applied Optics, Vol. 24, No. 21, 1 November 1985, pp. 3433-3434.

\* Copies of these references are not enclosed pursuant to 37 CFR 1.98(d). (See accompanying IDS)